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With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

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2SD2136

Silicon NPN triple diffusion planar type

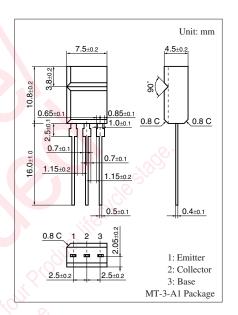
For power amplification Complementary to 2SB1416

■ Features

- High forward current transfer ratio h_{FE} which has satisfactory linearity.
- \bullet Low collector-emitter saturation voltage $V_{\text{CE}(\text{sat})}$
- Allowing supply with the radial taping

■ Absolute Maximum Ratings $T_a = 25$ °C

Parameter	Symbol	Rating	Unit	
Collector-base voltage (Emitter open)	V _{CBO}	60	V	
Collector-emitter voltage (Base open)	V _{CEO}	60	V	
Emitter-base voltage (Collector open)	V_{EBO}	6	V	
Collector current	I_{C}	3	A	
Peak collector current	I_{CP}	5	A	
Collector power dissipation	P_{C}	1.5	W	
Junction temperature	T _j	150	°C ,	
Storage temperature	T _{stg}	-55 to +150	°C	
Collector power dissipation Junction temperature	P _C	1.5	W °C	



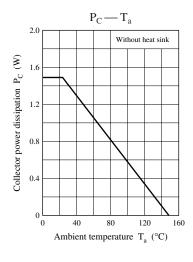
■ Electrical Characteristics $T_a = 25^{\circ}C \pm 3^{\circ}C$

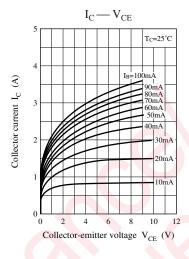
Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector-emitter voltage (Base open)	V _{CEO}	$I_C = 30 \text{ mA}, I_B = 0$	60	, YIC	•	V
Base-emitter voltage *1	V_{BE}	$V_{CE} = 4 \text{ V}, I_{C} = 3 \text{ A}$	100	80,	1.8	V
Collector-emitter cutoff current (Emitter-base short)	I _{CES}	$V_{CE} = 60 \text{ V}, V_{BE} = 0$)·	200	μΑ
Collector-emitter cutoff current (Base open)	I_{CEO}	$V_{CE} = 30 \text{ V}, I_{B} = 0$	7.60		300	μΑ
Emitter-base cutoff current (Collector open)	I_{EBO}	$V_{EB} = 6 \text{ V}, I_{C} = 0$			1	mA
Forward current transfer ratio	h _{FE1} *2	$V_{CE} = 4 \text{ V}, I_{C} = 1 \text{ A}$	40		250	_
	h _{FE2} *1	$V_{CE} = 4 \text{ V}, I_{C} = 3 \text{ A}$	10			
Collector-emitter saturation voltage *1	V _{CE(sat)}	$I_C = 3 \text{ A}, I_B = 0.375 \text{ A}$			1.2	V
Transition frequency	f_T	$V_{CE} = 5 \text{ V}, I_{E} = -0.1 \text{ A}, f = 200 \text{ MHz}$		220		MHz
Turn-on time	t _{on}	$I_C = 1 \text{ A}, I_{B1} = 0.1 \text{ A}, I_{B2} = -0.1 \text{ A}$		0.5		μs
Storage time	t _{stg}			2.5		μs
Fall time	t _f			0.4		μs

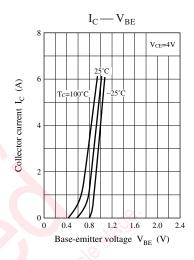
Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

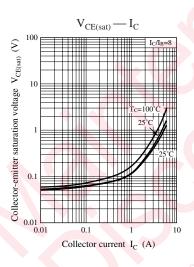
- 2. *1: Pulse measurement
 - *2: Rank classification

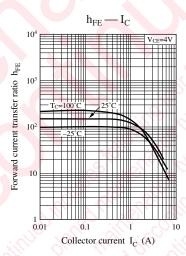
Rank	Р	Q	R
h_{FE1}	40 to 90	70 to 150	120 to 250

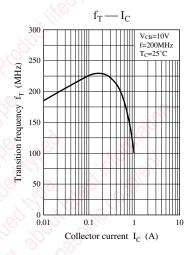


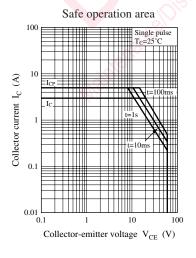


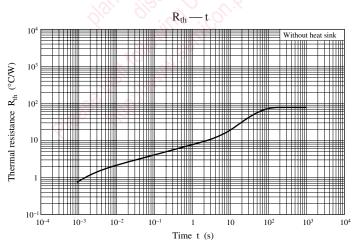












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